

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination LEE, SEOK-JIN	
		Examiner Tran N. Nguyen	Art Unit 2834	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-5,142,178	08-1992	Kloster et al.	310/217
X	B	US-4,469,970	09-1984	Neumann, Thomas W.	310/156.78
X	C	US-5,097,166	03-1992	Mikulic, Kreso	310/156.83
X	D	US-2,944,171	07-1960	ALGER PHILIP L	310/211
X	E	US-4,403,161	09-1983	Miyashita et al.	310/156.83
X	F	US-4,188,554	02-1980	Binns, Kenneth J.	310/156.78
X	G	US-4,144,469	03-1979	Miyashita et al.	310/156.28
X	H	US-3,590,208	06-1971	Martini et al.	219/92
X	I	US-4,728,842	03-1988	Martin, Benson D.	310/217
X	J	US-5,142,178	08-1992	Kloster et al.	310/217
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.